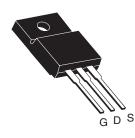


## LIZ34G-VB Datasheet N-Channel 60 V (D-S) MOSFET

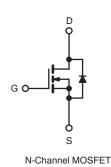
PRODUCT SUMMARY						
V <sub>DS</sub> (V)	60					
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = 10 V	0.027				
Q <sub>g</sub> (Max.) (nC)	95					
Q <sub>gs</sub> (nC)	27					
Q <sub>gd</sub> (nC)	46					
Configuration	Single					

#### **FEATURES**

- · Isolated Package
- High Voltage Isolation = 2.5 kV<sub>RMS</sub> (t = 60 s; f = 60 Hz)
- Sink to Lead Creepage Distance = 4.8 mm
- 175 °C Operating Temperature
- Dynamic dV/dt Rating
- Low Thermal Resistance
- · Lead (Pb)-free Available



**TO-220 FULLPAK** 



ABSOLUTE MAXIMUM RATINGS  $T_C = 25$  °C, unless otherwise noted SYMBOL PARAMETER LIMIT UNIT 60 **Drain-Source Voltage**  $V_{DS}$ v Gate-Source Voltage ± 20  $V_{GS}$  $T_C = 25 \ ^{\circ}C$ 45 V<sub>GS</sub> at 10 V **Continuous Drain Current**  $I_D$  $T_C = 100 \degree C$ А 30 Pulsed Drain Currenta I<sub>DM</sub> 220 Linear Derating Factor 0.32 W/°C Single Pulse Avalanche Energy<sup>b</sup> E<sub>AS</sub> 100 mJ T<sub>C</sub> = 25 °C Maximum Power Dissipation 52 W  $\mathsf{P}_\mathsf{D}$ Peak Diode Recovery dV/dtc dV/dt V/ns 4.5 - 55 to + 175 Operating Junction and Storage Temperature Range T<sub>J</sub>, T<sub>stg</sub> °C Soldering Recommendations (Peak Temperature) for 10 s 300<sup>d</sup> 10 lbf · in Mounting Torque 6-32 or M3 screw N·m 1.1

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b.  $V_{DD} = 25 \text{ V}$ , starting  $T_J = 25 \text{ °C}$ , L = 129  $\mu$ H,  $R_G = 25 \Omega$ ,  $I_{AS} = 30 \text{ A}$  (see fig. 12). c.  $I_{SD} \le 52 \text{ A}$ , dI/dt  $\le 250 \text{ A}/\mu$ s,  $V_{DD} \le V_{DS}$ ,  $T_J \le 175 \text{ °C}$ .

d. 1.6 mm from case.

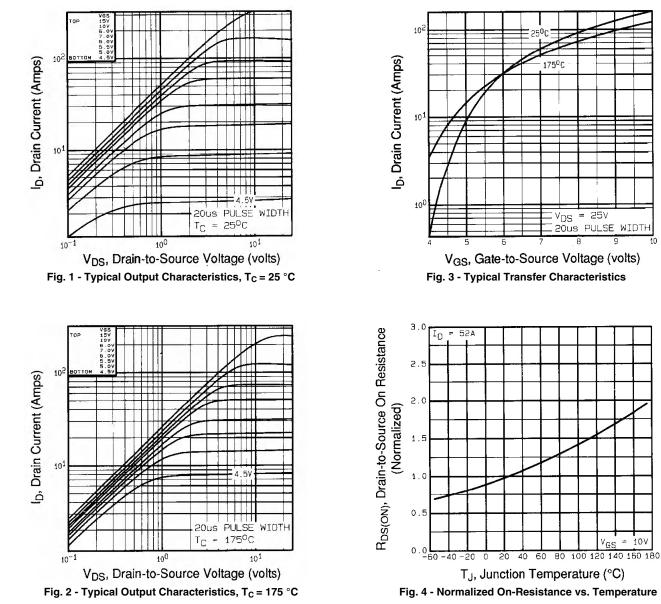
THERMAL RESISTANCE RAT	<b>FINGS</b>								
PARAMETER	SYMBOL	TYP. MAX.			UNIT				
Maximum Junction-to-Ambient	R <sub>thJA</sub>	- 65							
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	- 3.1				°C/W			
<b>SPECIFICATIONS</b> T <sub>J</sub> = 25 °C, 1	unless otherv	vise noted							
PARAMETER	SYMBOL	TEST CONDITIONS			MIN.	TYP.	MAX.	UNI	
Static							1		
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA			60	-	-	V	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	Reference to 25 °C, $I_D = 1$ mA			0.060	-	V/°	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \mu A$			1.0	-	3.0	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{GS} = \pm 20 \text{ V}$			-	-	± 100	nA	
6		V <sub>DS</sub> =	$V_{DS} = 60 V, V_{GS} = 0 V$			-	25	μΑ	
Zero Gate Voltage Drain Current	ain Current $I_{DSS}$ $V_{DS} = 48 \text{ V}, \text{ V}_{GS} = 0 \text{ V}, \text{ T}_{J} = 150 ^{\circ}\text{C}$		T <sub>J</sub> = 150 °C	-	-	250			
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V I <sub>D</sub> = 18 A <sup>b</sup>		-	0.027	-	Ω		
Forward Transconductance	g <sub>fs</sub>	$V_{DS} = 25 \text{ V}, \text{ I}_{D} = 18 \text{ A}^{b}$		15	-	-	S		
Dynamic					•	<b>I</b>		1	
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 25 V, f = 1.0 MHz, see fig. 5 f = 1.0 MHz			-	1500	-		
Output Capacitance	C <sub>oss</sub>			-	720	-	рF		
Reverse Transfer Capacitance	C <sub>rss</sub>			-	100	-			
Drain to Sink Capacitance	С			-	12	-			
Total Gate Charge	Qg			-	-	95			
Gate-Source Charge	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V	$I_{\rm D} = 52$ /	2 A, V <sub>DS</sub> = 48 V, fig. 6 and 13 <sup>b</sup>	-	-	27	nC	
Gate-Drain Charge	Q <sub>gd</sub>	-	See no	J. 6 anu 13ª	-	-	46		
Turn-On Delay Time	t <sub>d(on)</sub>				-	19	-		
Rise Time	tr	$\label{eq:V_DD} \begin{array}{l} V_{DD} = 30 \; V, \; I_D = 52 \; A, \\ R_G = 9.1 \; \Omega, \; R_D = 0.54 \; \Omega, \\ \text{see fig. } 10^b \end{array}$		-	120	-	- ns		
Turn-Off Delay Time	t <sub>d(off)</sub>			-	55	-			
Fall Time	tf			-	86	-			
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	nH		
Internal Source Inductance	LS			-	7.5	-			
Drain-Source Body Diode Characteristic	S				1	1	1	1	
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the		-	-	45	A		
Pulsed Diode Forward Currenta	I <sub>SM</sub>	integral reverse p - n junction diode			-	-		120	
Body Diode Voltage	$V_{SD}$	$T_{\rm J} = 25 \ ^{\circ}{\rm C}, \ I_{\rm S} = 30 \ {\rm A}, \ V_{\rm GS} = 0 \ {\rm V}^{\rm b}$		-	-	2.5	V		
Body Diode Reverse Recovery Time	t <sub>rr</sub>			-	140	300	ns		
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	$T_J = 25 \text{ °C}, I_F = 52 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}^b$			-	1.2	2.8	μΟ	
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S$ and $L_D$ )							

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %.

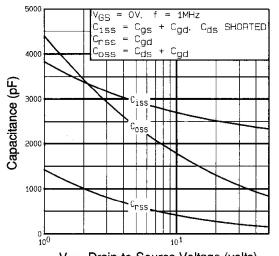


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#### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





V<sub>DS</sub>, Drain-to-Source Voltage (volts) Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

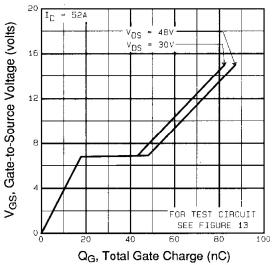


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

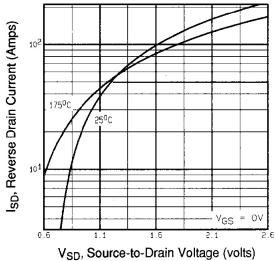
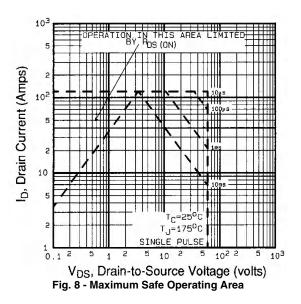


Fig. 7 - Typical Source-Drain Diode Forward Voltage



### LIZ34G-VB



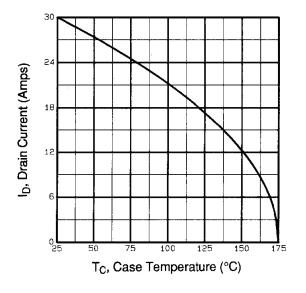


Fig. 9 - Maximum Drain Current vs. Case Temperature

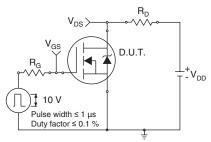


Fig. 10a - Switching Time Test Circuit

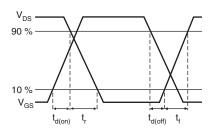


Fig. 10b - Switching Time Waveforms

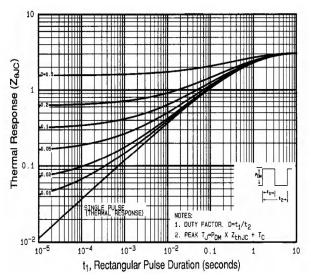
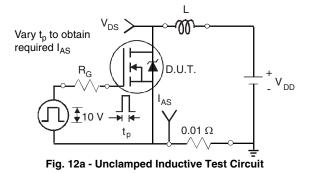


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



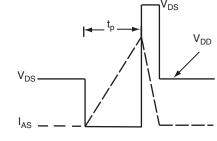
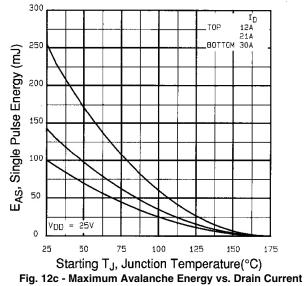


Fig. 12b - Unclamped Inductive Waveforms







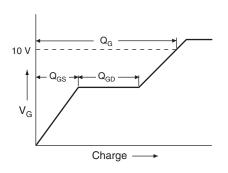
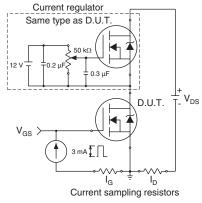
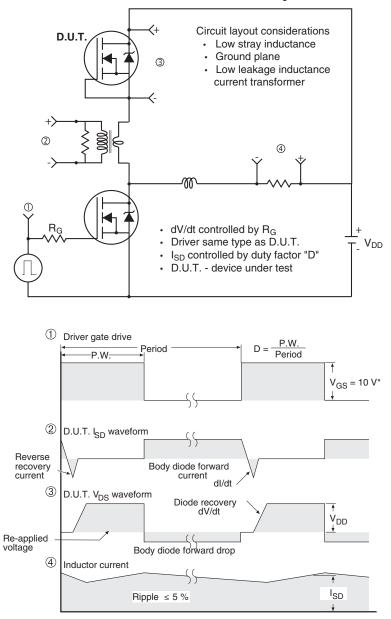


Fig. 13a - Basic Gate Charge Waveform









Peak Diode Recovery dV/dt Test Circuit

\*  $V_{GS} = 5$  V for logic level devices

Fig. 14 - For N-Channel



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